

Micro Resolution Chart for X-Ray

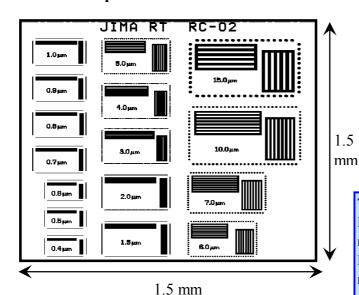
(Resolution Test-patterns for micro-focus X-ray images)

MARTRO-02

Price 180,000 Yen plus shipping

Micro-focus type of X-ray inspection systems are currently in common use. The micro-chart is most indispensable to adjust focus-point (size / shape) for X-ray images. In genera, it is necessary to maintain the capability of X-ray systems . This micro-chart has been fabricated by using the latest semiconductor lithography techniques. As the result, sub-micron slits down to 0.4 micron could be achieve. (0.4, 0.5, 0.6, 0.7, 0.8, 0.9, 1.0, 1.5, 2.0, 3.0, 4.0, 5.0, 6.0, 7.0, 10.0, 15.0 μ m, 16 different width) JIMA (Japan Inspection Instruments Manufacturers' Association) has succeeded to supply with an economical price by quantity produce.

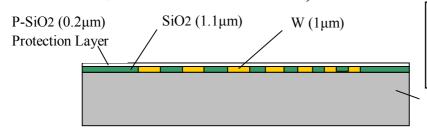
■ Line and Space Pattern



2.0 μm 190 μm

The layout of slits is designed at Horizontal and Perpendicular position as above drawing for 2.0 micron. Black lines are Tungsten absorption material. Each width of Tungsten and space are same 2.0 micron. The number of lines is 7 lines (15 micron has only 5 lines.). The outer edge is surrounded by wider line of Tungsten.

■ Cross Section (Si Base thickness: 60 micron)



Tungsten chart is drawn on 5 mm square Si base filling the gap with SiO2, then polished to have nearly 1 micron thickness. And Si block is fixed on 30x40 mm Aluminum plate.

Si Base

Specification

- 1. Whole Size: 40x30x5 mm
- 2. Si Plate: 5x5x0.06 mm
- 3. Absorption Material: Tungsten (W) 1.0

 µm Thickness
- 4. Protection Film: Plycarbonate 0.1 mm Thickness
- 5. Tolerance of Slit width and space: +/- 10% or less under 2µm, +/- 8% or less over 3µm (At 23 degree C)
- 6. Slit Width: 0.4, 0.5, 0.6, 0.7, 0.8, 0.9, 1.0, 1.5, 2.0, 3.0, 4.0, 5.0, 6.0, 7.0, 10.0, 15.0μm, 16 size
- 7. Number of Slit: 7 (Only 15µm: 5)
- 8. Protection Case included

Micro-Chart, Certification, Operation Manual

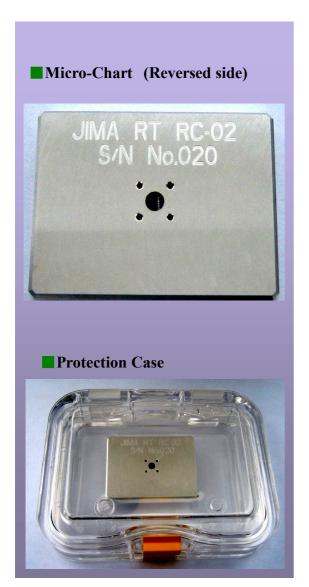
9. Operation Temparature Range: 10°C to 70°C

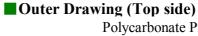




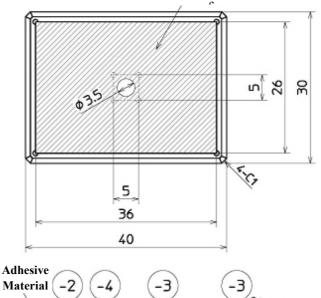
Japan Inspection Instruments Manufacturers Association http://www.jima.jp

Micro Resolution Chart for X-Ray Resolution Test-patterns for micro-focus X-ray images





Polycarbonate Protection Film on the



	(-1)		
No.	Parts	Material	Size(mm)
-1	Aluminum Plate	A2017P	40x30x5
-2	Protection Film	Polycarbonate	36x26x0.1
-3	Adhesive Material	Silicon	_
-4	Silicon Base	S	5x5x0.06
	Absorption Material	W	t=1.0um

Ordering:

Please send Purchase Order Sheet. We will send invoice for advanced payment.

We will ship within 10 days after confirmation of your remittance.

Note: Bank Cahrge and Shipping Charge should be paid by the customer.

(Questions / Ordering to:) **RT Test Piece Handling: Nihon Matech** Corporation

TEL: 03-3221-7531 FAX: 03-3221-7240 E-mail: rttp@jima.jp

Specification can be modified without any previous notice. Please confirm.

Exlusively Sold by:



Japan Inspection Instruments Manufacturers' Association

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